es of each polytypes. The simulated data by Warren and Averbach method(B.E. Warren & B.L. Averbach, *J. Appl Phys.*,, 21(1950): 595-599; 23(1952): 1059) with 4H, 3C, 6H and 15R polytypes and two specimens from the same nano material were used to test this approach.

The results show that the distribution of SiC polytypes can be accurately and reliably determined by this approach. It can be applied in nano-material case.

PS10.01.10 ISOTROPIC MATERIALS WITH LOW OR NEGATIVE THERMAL EXPANSION. Nazy Khosrovani, Arthur W. Sleight, Department of Chemistry, Gilbert Hall, 153 Corvallis, Oregon, 97331-4003

Materials which contract on heating (negative thermal expansion materials) are of great importance since they can be mixed with other materials (positive thermal expansion materials) to make composites which have zero thermal expansion. Materials with zero or low thermal expansion have many applications in electronic devices, space telescope mirrors, stove tops, cook wares and so on.

There are two types of low or negative thermal expansion materials. The first type have anisotropic thermal expansion which means that on heating, the structure will expand in one or two dimensions and contract in the other dimension(s). Examples of anisotropic materials are  $\beta$ -eucryptite, cordierite, and NZP (NaZr<sub>2</sub>P<sub>3</sub>O<sub>12</sub>). The problem with anisotropic materials is that microcracking occurs during the heating cycle. The second type of materials have isotropic thermal expansion which means that on heating, the structure will contract (or expand) in all dimensions. Examples of isotropic materials with low or negative thermal expansion are ZrP<sub>2</sub>O<sub>7</sub> and ZrV<sub>2</sub>O<sub>7</sub> respectively.

We have solved the structures of  $ZrP_2O_7$  and  $ZrV_2O_7$ , and found that  $ZrP_2O_7$  shows normal thermal expansion up to about 290°C at which the phase transition occurs, and very low and positive thermal expansion after 290°C. However,  $ZrV_2O_7$  shows positive thermal expansion up to about 100°C, and very strong negative thermal expansion after 100°C up to about 800°C at which the material decomposes. There are two phase transitions observed for  $ZrV_2O_7$  before 100°C which makes the structure more challenging.

The structure of both  $ZrP_2O_7$  and  $ZrV_2O_7$  is cubic and the space group is Pa3. A 3x3x3 superstructure is observed for both compounds at room temperature. The 3x3x3 superstructure disappears after the phase transition is achieved in  $ZrP_2O_7$ , but it doesn't fully disappear until the second phase transition is achieved in  $ZrV_2O_7$ . We believe that the unusual thermal expansion of these compounds is a result of frustration in bending some of the P-O-P or V-O-V angles away from  $180^\circ$ .

Khosrovani, N.; Sleight A.W., Inorg. Chem. 35, 485 (1996)

PS10.01.11 STRUCTURE OF CUBIC YTTRIA DOPED ZIRCONIA BY SYNCHROTRON RADIATION. Y. Matsushima, M. Hayashi, K. Suda, Y. Tabira, N. Ishizawa, Research Laboratory of Engineering Materials, Tokyo Institute of Technology, Nagatsuta, Midori-ku, Yokohama 226, Japan

The structure of yttria-doped zirconia,  $(Zr_{1-x}Y_x)O_{2-x/2}$  with x=0.242 has been studied by both the synchrotron radiation singlecrystal diffraction and EXAFS. The diffraction experiment on a spherical crystal with 35 µm in diameter was carried out using a horizontal-type four circle diffractometer at the beam line 14A, KEK-PF. Two wave lengths of 0.7281 Å and 0.75 Å, corresponding to the energies 10 eV and 500 eV below the Y K absorption edge respectively, were employed to enhance the scattering contrast between Y and Zr. The EXAFS spectra of the powdered sample near the Y and Zr K absorption edges were also measured at BL14A employing the transmission mode. The refinements using 83 independent reflections for the 0.75 Å data set and 90 for the 0.7281 Å data set converged with R/Rw factors of 0.0053/0.0051 and of 0.0074/0.0066 respectively. In contrast to the conventional understanding of the fluorite-type structure of this compound, Zr atoms are presumably displaced by about 0.17 Å along <111> from the origin, while Y atoms stay at the origin. In addition, about one third of oxygen atoms are displaced by about 0.35 Å along <001> from the ideal position at 8c site 1/4,1/4,1/4 of the space group Fm3m. The final residual electron density maps indicated that the oxygen atoms near the 8c sites suffer a conspicuous third order enharmonic vibration along <111>, suggesting a possible diffusion path toward the nearest vacant sites of 4b 1/2,1/2,1/2. EXAFS results indicated that Zr-O bond is 2.15(1) Å that is much shorter than the Y-O of 2.32(1) Å. The coordination number of Zr-O is 8.2 and that of Y-O is 6.2. Combining the results of the EXAFS and the single crystal diffraction, it is suggested that Y and Zr atoms have local structures similar to those found in their parent end-member oxides respectively.

PS10.01.12 STRUCTURE AND PROPERTIES OF COMPLEX PEROVSKITE MICROWAVE CERAMIC DIELECTRIC RESONATORS. H. Sreemoolanadhan, R. Ratheesh, M. T. Sebastian, P. Mohanan, Electronic Ceramics, Regional Research Laboratory, Thiravananthapuram-695 019, India \*Electronics Department, Cochin Univ. of Sci. & Tech., Thrikkakara-682 022, India

Ceramic materials with high dielectric constant and low loss called 'dielectric resonators (DR)' have become indispensable components for both active and passive devices in modern microwave systems. Ba(B' $_{1/2}$  Nb $_{1/2}$ )O3 [B' = La, Pr, Nd, Sm, In, Tb, Y, Gd, Er] complex perovskites have been prepared as a microwave dielectric ceramic resonator material. They have high  $\epsilon_r$ (30-45), low loss and very small temperature variation of resonant frequency in the microwave range. Several earlier workers reported that these materials have cubic symmetry with (NH $_4$ )<sub>3</sub>FeF $_6$  structure. Recent studies show that these materials have a cubic symmetry at high temperature and transforms to one with a lower symmetry (tetragonal, orthorhombic or monoclinic) on cooling. The mechanism of the transition and its relation to the tolerance factor, difficulties of X-ray diffraction to find the transition and the correct symmetry and dielectric properties of these materials are discussed.